

SLOVENSKI STANDARD
SIST EN 55016-2-3:2010**01-december-2010****Nadomešča:****SIST EN 55016-2-3:2007****Specifikacija merilnih naprav in metod za merjenje radijskih motenj in odpornosti -
2-3. del: Metode za merjenje radijskih motenj in odpornosti - Merjenje sevanih
motenj**

Specification for radio disturbance and immunity measuring apparatus and methods -
Part 2-3: Methods of measurement of disturbances and immunity - Radiated disturbance
measurements

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Anforderungen an Geräte und Einrichtungen sowie Festlegung der Verfahren zur
Messung der hochfrequenten Störaussendung (Funkstörungen) und Störfestigkeit - Teil
2-3: Verfahren zur Messung der hochfrequenten Störaussendung (Funkstörungen) und
Störfestigkeit - Messung der gestrahlten Störaussendung

Spécifications des méthodes et des appareils de mesure des perturbations
radioélectriques et de l'immunité aux perturbations radioélectriques - Partie 2-3:
Méthodes de mesure des perturbations et de l'immunité - Mesures des perturbations
rayonnées

Ta slovenski standard je istoveten z: EN 55016-2-3:2010**ICS:**

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English version

**Specification for radio disturbance and immunity measuring apparatus
 and methods -
 Part 2-3: Methods of measurement of disturbances and immunity -
 Radiated disturbance measurements
 (CISPR 16-2-3:2010)**

Spécifications des méthodes
 et des appareils de mesure
 des perturbations radioélectriques
 et de l'immunité aux perturbations
 radioélectriques -
 Partie 2-3: Méthodes de mesure
 des perturbations et de l'immunité -
 Mesures des perturbations rayonnées
 (CISPR 16-2-3:2010)

Anforderungen an Geräte
 und Einrichtungen sowie Festlegung
 der Verfahren zur Messung
 der hochfrequenten Störaussendung
 (Funkstörungen) und Störfestigkeit -
 Teil 2-3: Verfahren zur Messung
 der hochfrequenten Störaussendung
 (Funkstörungen) und Störfestigkeit -
 Messung der gestrahlten Störaussendung
 (CISPR 16-2-3:2010)

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 Comité Européen de Normalisation Electrotechnique
 Europäisches Komitee für Elektrotechnische Normung

Management Centre: Avenue Marnix 17, B - 1000 Brussels

Foreword

The text of document CISPR/A/886/FDIS, future edition 3 of CISPR 16-2-3, prepared by CISPR SC A, Radio-interference measurements and statistical methods, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 55016-2-3 on 2010-06-01.

This European Standard supersedes EN 55016-2-3:2006.

This EN 55016-2-3:2010 includes the following significant technical changes with respect to EN 55016-2-3:2006: addition of the measurand for radiated emissions measurements in an OATS and a SAC in the range of 30 MHz to 1 000 MHz, and addition of a new normative annex on the determination of suitability of spectrum analysers for compliance tests. Also, numerous maintenance items are addressed to make the standard current with respect to other parts of the EN 55016 series.

It has the status of a basic EMC publication in accordance with IEC Guide 107, *Electromagnetic compatibility – Guide to the drafting of electromagnetic compatibility publications*.

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The following dates were fixed:

- latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2011-03-01
- latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2013-06-01

Annex ZA has been added by CENELEC [SIST EN 55016-2-3:2010](https://standards.iteh.ai/catalog/standards/sist/7d1b05b4-7218-45a7-b6a8-fe6cf02eb347/sist-en-55016-2-3-2010)
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Endorsement notice

The text of the International Standard CISPR 16-2-3:2010 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

- | | | |
|------------------------|------|---|
| [1] CISPR 11:2009 | NOTE | Harmonized as EN 55011:2009 (modified). |
| [3] CISPR 22:2008 | NOTE | Harmonized as EN 55022:200X ¹⁾ (modified). |
| [4] IEC 61140:2001 | NOTE | Harmonized as EN 61140:2002 (not modified). |
| [6] ISO/IEC 17000:2004 | NOTE | Harmonized as EN ISO/IEC 17000:2004 (not modified). |
| [7] IEC 61000-4-21 | NOTE | Harmonized as EN 61000-4-21. |

¹⁾ At draft stage.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

| <u>Publication</u> | <u>Year</u> | <u>Title</u> | <u>EN/HD</u> | <u>Year</u> |
|--------------------|-------------|---|--------------|-------------|
| CISPR 14-1 | 2005 | Electromagnetic compatibility - Requirements for household appliances, electric tools and similar apparatus - Part 1: Emission | EN 55014-1 | 2006 |
| CISPR 16-1-1 | - | Specification for radio disturbance and immunity measuring apparatus and methods - Part 1-1: Radio disturbance and immunity measuring apparatus - Measuring apparatus | EN 55016-1-1 | - |
| CISPR 16-1-2 | 2003 | Specification for radio disturbance and immunity measuring apparatus and methods - Part 1-2: Radio disturbance and immunity measuring apparatus - Ancillary equipment - Conducted disturbances | EN 55016-1-2 | 2004 |
| CISPR 16-1-4 | 2010 | Specification for radio disturbance and immunity measuring apparatus and methods - Part 1-4: Radio disturbance and immunity measuring apparatus - Antennas and test sites for radiated disturbance measurements | EN 55016-1-4 | 2010 |
| CISPR 16-2-1 | 2008 | Specification for radio disturbance and immunity measuring apparatus and methods - Part 2-1: Methods of measurement of disturbances and immunity - Conducted disturbance measurements | EN 55016-2-1 | 2009 |
| CISPR 16-4-1 | - | Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-1: Uncertainties, statistics and limit modelling - Uncertainties in standardized EMC tests | - | - |
| CISPR 16-4-2 | - | Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-2: Uncertainties, statistics and limit modelling - Uncertainty in EMC measurements | EN 55016-4-2 | - |
| CISPR/TR 16-4-5 | - | Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-5: Uncertainties, statistics and limit modelling - Conditions for the use of alternative test methods | - | - |

| <u>Publication</u> | <u>Year</u> | <u>Title</u> | <u>EN/HD</u> | <u>Year</u> |
|--------------------|-------------|--|---------------|-------------|
| IEC 60050-161 | 1990 | International Electrotechnical Vocabulary (IEV) - Chapter 161: Electromagnetic compatibility | - | - |
| IEC 61000-4-3 | 2006 | Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test | EN 61000-4-3 | 2006 |
| IEC 61000-4-20 | - | Electromagnetic compatibility (EMC) - Part 4-20: Testing and measurement techniques - Emission and immunity testing in transverse electromagnetic (TEM) waveguides | EN 61000-4-20 | - |

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Mesures des perturbations rayonnées

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INTERNATIONAL ELECTROTECHNICAL COMMISSION
INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

**SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY
MEASURING APPARATUS AND METHODS –**

**Part 2-3: Methods of measurement of disturbances and immunity –
Radiated disturbance measurements**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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This consolidated version of CISPR 16-2-3 consists of the third edition (2010) [documents CISPR/A/886/FDIS and CISPR/A/892/RVD and its amendment 1 (2010) [documents CISPR/A/878/CDV and CISPR/A/894/RVC]. It bears the edition number 3.1.

The technical content is therefore identical to the base edition and its amendment and has been prepared for user convenience. A vertical line in the margin shows where the base publication has been modified by amendment 1. Additions and deletions are displayed in red, with deletions being struck through.

International Standard CISPR 16-2-3 has been prepared by CISPR subcommittee A: Radio-interference measurements and statistical methods.

This edition includes the following significant technical changes with respect to the previous edition: addition of the measurand for radiated emissions measurements in an OATS and a SAC in the range of 30 MHz to 1 000 MHz, and addition of a new normative annex on the determination of suitability of spectrum analysers for compliance tests. Also, numerous maintenance items are addressed to make the standard current with respect to other parts of the CISPR 16 series.

It has the status of a basic EMC publication in accordance with IEC Guide 107, *Electromagnetic compatibility – Guide to the drafting of electromagnetic compatibility publications*.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the CISPR 16 series, published under the general title *Specification for radio disturbance and immunity measuring apparatus and methods*, can be found on the IEC website.

The committee has decided that the contents of the base publication and its amendments will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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INTRODUCTION (to amendment 1)

The recent addition of FFT-based measuring instrumentation in CISPR 16-1-1 necessitates the addition of related specifications for the test methods covered in CISPR 16-2-3. Those new specifications are introduced in this amendment.

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[SIST EN 55016-2-3:2010](https://standards.iteh.ai/catalog/standards/sist/7d1b05b4-7218-45a7-b6a8-fe6cf02eb347/sist-en-55016-2-3-2010)

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